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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Toshihiro NAKAYAMA Confirmation No.: 9559

Appln. No. : 09/608,008 Examiner: R.R. Yang

Filed : June 30, 2000 Group Art Unit: 2672

For : IMAGE PROCESSING COMPUTER SYSTEM FOR PHOTOGRAMMETRIC ANALYTIC MEASUREMENT

COMMENTS ON STATEMENT OF REASONS FOR ALLOWANCE

Commissioner for Patents
 U.S. Patent and Trademark Office
 Customer Service Window, Mail Stop Issue Fees
 Randolph Building
 401 Dulany Street
 Alexandria, VA 22314

Sir :

In response to the Notice of Allowability, mailed by the Patent and Trademark Office on March 25, 2005 and to the Statement of Reasons for Allowance attached thereto, Applicant wishes to clarify the record with respect to the basis for the patentability of claims in the present application. In this regard, while Applicant does not disagree with the Examiner's indication that certain identified features are not disclosed by the references, Applicant submits that each of the claims in the present application recite a particular combination of features, and that the basis for patentability of each of these claims is based on the totality of the particular features recited therein.

Should there be any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully submitted,
 Toshihiro NAKAYAMA

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May 24, 2005
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